

**Search Notes**

Application/Control No.

10/520,136

Examiner

Karen Cheng

Applicant(s)/Patent under  
Reexamination

LUU ET AL.

Art Unit

1626

**SEARCHED**

Class	Subclass	Date	Examiner
548	509	7/30/2007	KC
514	415	7/30/2007	KC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
514	415	7/30/2007	KC
548	509	7/30/2007	KC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (see attached)	7/25/2007	KC
EAST Search (including interference, see attached)	7/30/2007	KC